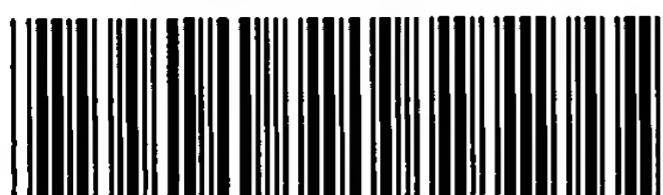


Search Notes



Application/Control No.

10/679,771

Examiner

Richard H. Kim

**Applicant(s)/Patent under
Reexamination**

HAN ET AL.

Art Unit

2871

SEARCHED

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)